



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application of

FROGGATT

Atty. Ref.: 3926-3

Serial No. 10/005,819

TC/A.U.: 2877

Filed: December 14, 2001

Examiner: S. Turner

For: APPARATUS AND METHOD FOR THE COMPLETE
CHARACTERIZATION OF OPTICAL DEVICES INCLUDING LOSS,
BIREFRINGENCE AND DISPERSION EFFECTS

* * * * *

April 16, 2004

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

INFORMATION DISCLOSURE STATEMENT

As suggested by 37 C.F.R. 1.97, the undersigned attorney brings to the attention of the Patent and Trademark Office the reference listed on the attached form PTO-1449, a copy of each of which is enclosed. This is not to be construed as a representation that a search has been made or that no better prior art exists, or that a reference is relevant merely because cited.

The Examiner is requested to initial the attached form PTO-1449 and to return a copy of the initialed document to the undersigned as an indication that the attached references have been considered and made of record.

Respectfully submitted,

NIXON & VANDERHYE P.C.

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By:



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of

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	6,151,428	11/00	Vahala et al.			
	2002/0113972A1	8/02	Rosenfeldt et al.			
	5,173,743	12/92	Kim			
	6,160,826	12/00	Swanson et al.			
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	5,323,258	6/94	Tsushima et al.			
	5,469,455	11/95	Reitz et al.			
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	6,385,358	5/02	Everett et al.			
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DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
6-34446	2/8/94	Japan			ABSTRACT	
2001-41706	2/16/01	Japan			ABSTRACT	
2001-91408	4/6/01	Japan			ABSTRACT	

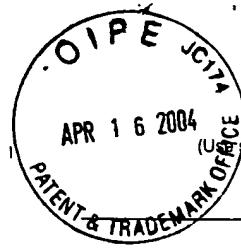
OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

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*Examiner

Date Considered

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				CLASS	SUBCLASS	IF APPROPRIATE
	4,718,120	1/88	Tzeng			
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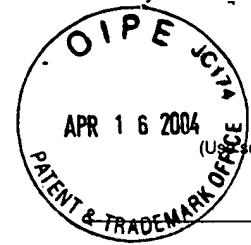
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	Sensitive Collinear Laser Spectroscopy on Fast Atom and Ion Beams, H. K. Carter, pages 60-64.
	The Vibrational Predissociation Lifetime of the HF Dimer Upon Exciting the "free-H" Stretching Vibration, Huang et al., J. Chem. Phys. 85(6), 9/15/86, pages 3338-3341.
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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	FILING DATE CLASS SUBCLASS IF APPROPRIATE		
	2003/0016425A1	1/03	Tan et al.			
	2002/0167670A1	11/02	Baney			
	2003/0063285A1	4/03	Pering			
	2003/0011777A1	1/03	Szafraniec et al.			
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	<p>Diode Laser Spectra With Simultaneous Frequency Calibration, A. Chraplyvy, Applied Optics, Vol. 17, No. 17, September 1, 1978.</p>
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A circular stamp with "U.S. PATENT & TRADEMARK OFFICE" around the perimeter, "WASHINGTON, D.C." at the top, and "APR 16 2004" in the center. Below the date, it says "(Use back)" and "SC174".

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